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## Internal Level 2



<b>Revision Histor</b>	$^{\prime}$ $^{\prime}$ – see Workflow History for approvers and approval dates, and Notice for release dates
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Rev	Notice #	Description	Author	Revision Date

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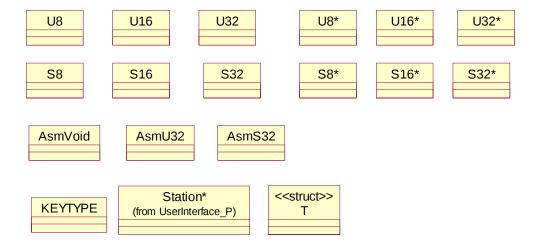
Follow are the Software Structure we mentioned in HLD. In LLD, we will explain class diagram and Sequence Diagram according the Software Layer we use in BLTC design.

UserInterface (UI_IR, UI_RS232, UI_FrontPanel, UI_StationTest, UI_AllInOneTest)			
Items (Test Item, Action Item, Control Item)			
TiApi			
TiLib	TvMonCmd		
TvMon or Broadcom or Third Party Libray , or any driverlayer code we did (for example Ethernet loop test)			

### 1. CLASS DIAGRAM

### 1.1. BLTC Basic Type

Broadcom used to using their basic type (U8, U16, ...). BLTC should avoid to define the same type name.



BltcBasicType.h contents as follow,

#include "gitypes.h" // "gitypes.h" include above type and const.

// Follows for Code Generation Function of QIP7xxx BLTC can work in Rational Ross (UML tool).

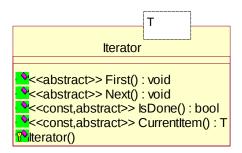
#define AsmVoid asm void #define AsmU32 asm U32 #define AsmS32 asm S32

Rational Ross be chosen as OOA (Object Oriented Analysis) tool. I made AsmVoid define since "asm void" will make the Rational Ross dead in Code Generation Function or Reverse Engineer Function.

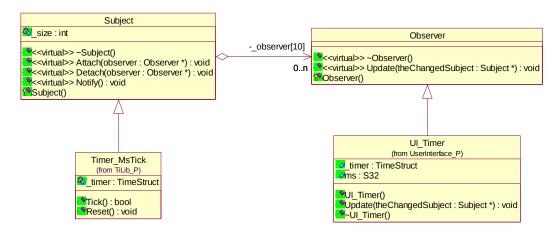
### 1.2. Pattern

A couple of pattern used in QIP7xxx BLTC design (Refer book, Design Patterns, published by Addison Wesley in 1995). They are:

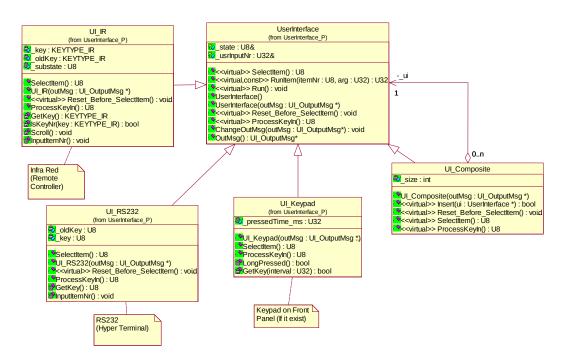
Iterator pattern

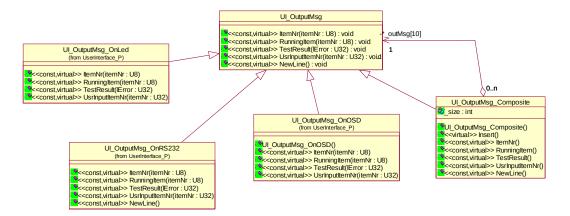


### Observer pattern

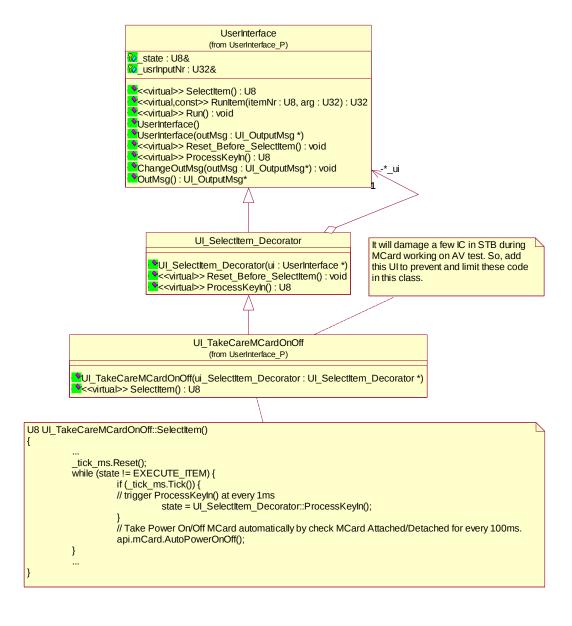


### Composite pattern





### Decorator pattern

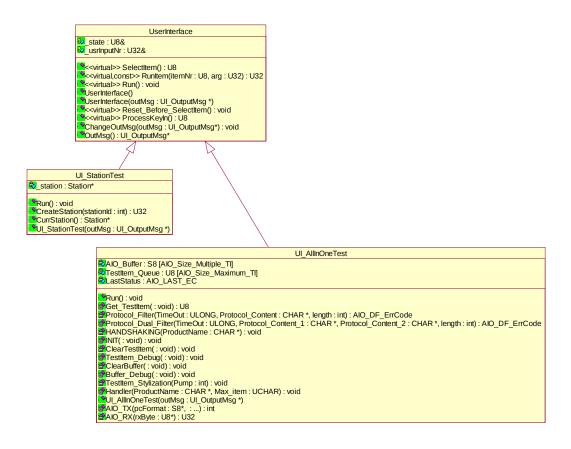


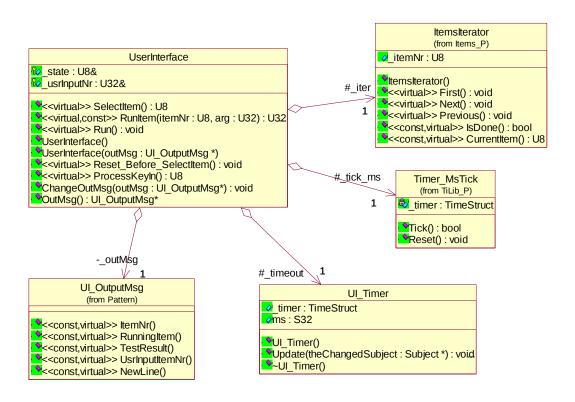
#### 1.3. User Interface

For lab, select test item by Remote Controller (IR: Infra Red) or Front Panel (Keypad) or RS232, run single test item for debug (UI\_IR, UI\_RS232, UI\_FrontPanel user interface), (refer Decorator Pattern as above).

In production-line, we using Station Test, UI\_StationTest, currently, and have a plan All In One Test, UI\_AllInOne, in future.







### **1.4.** Items

Give a number for each test item, it's purpose is to communicate with PE clearly.

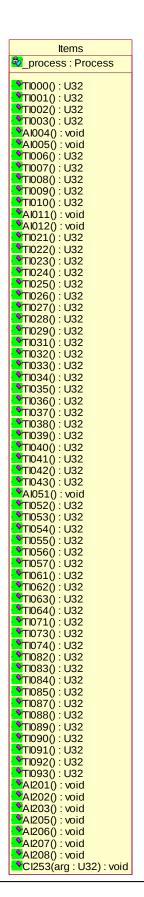
For example,

TI000: "Display station information on RS232, setting:(38400,8,O,1,n)"

TI103: "Tuner 1(64QAM, channel=8, pid=8c0 8c0 8c1) A/V test, and 1394 Tx Test"

TI105: "Tuner 1(256QAM, channel=6, pid=310 310 311) A/V test, and 1394 Tx Test"

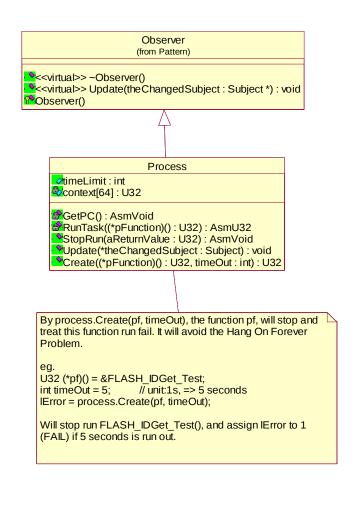
When operator report to PE, and PE told us the test item number has trouble, eg.103, then we know exactly the TI103: "Tuner1(64QAM)..." has trouble.

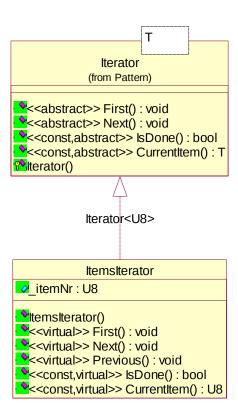


```
enum int type =
<<struct>>
                       {TEST_ITEM,
   Item
                       ACTION ITEM.
⊘id : U8
                       CONTROL_ITEM}

√type : S8

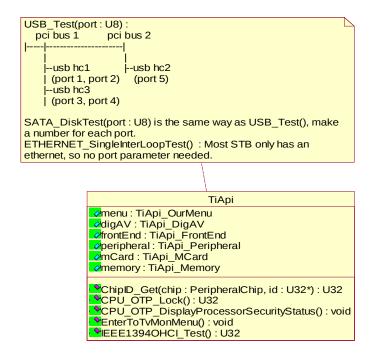
name : S8
                       //TEST ITEM
                       int Tlxx() {
                        return SUCCESS/FAIL;
                       // ACTION ITEM
                       void Alxx() {
                       // CONTROL_ITEM
                       void Clxx(char* arg) {
```

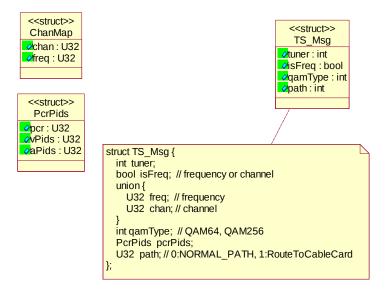




### 1.5. TiApi

The layer be called by layer items or above.





# TiApi\_DigAV PIP\_CreateTransportStream(tuner1 : TS\_Msg, tuner2 : TS\_Msg) : U32 ChangeChanMap(chanMap : ChanMap) : U32 OpenOutput(flag : int) : U32 OpenOutput\_All() : U32 CloseOutput(flag : int) : U32 EnableRemod() : void Audio\_Start\_Test\_Tone(stream : U32) : void CreateTransportStream(ts : TS\_Msg) : U32

```
TiApi_FrontEnd

QAM_SetFreq(tuner: int, freq: U32): U32

QAM_SetChan(tuner: int, chan: int): U32

QAM_SetPcrPids(tuner: int, pcrPids: PcrPids): U32

QAM_256Acq(tuner: int): U32

QAM_64Acq(tuner: int): U32

QAM_LockStatus(tuner: int): U32

QOB_Lock(Freq_Sel: int): U32

VCXO_Test(selFreq: U8): U32

QAM_Set_Brcm(tuner: int, freq: U32, qamType: int, tuneMode: U32): U32

QAM_GetLockStatus_Brcm(tuner: int): U32
```

```
RFU
(from TiApi_FrontEnd)

**Calibration(freq: U32, powerLevelDbmv: U32, foffset: float*): U32

**TestPower(freq: U32, powerLevelDbmv: U32): U32

**ClosePower(): U32

**SaveOffsetToNvsram(offset: float): U32

**SaveOffsetToPFD(offset: float): U32

**RFU_nit(): int
```

```
CLink
(from TiApi_FrontEnd)

DeviceProperty_Identify(:void): U32
ContinuousOutput_ChannelSet(CO_ChNum: U16): U32
ContinuousWave_Test(CW_ChNum: U16): U32
```

# TiApi\_MCard Init(): int PowerOn(): U32 IsLoaded(): U32 IsLoadedCardVersion(): U32 PowerOff(): U32 OOBDownStreamTest(): U32 AutoPowerOnOff(): void

```
TiApi_Memory

FLASH_IDGet(flashID: U16*): U32
FLASH_Protect(: void): U32
FLASH_ErasePfdSector(area: U8): U32
FLASH_ErasePfdSector(area: U32*, endAddr: U32*): U32
FLASH_dump_content(startAddr: U32*, endAddr: U32*): U32
DDR_RW_Test(testPattern: U32*, startAddr: U32, size: U32, Method: U32): U32
DDR_MaxSizeDetect(productName: S8*, getSize: U8*): U32
DDR_DCITransfer(pciDev: U8): U32
DMA_DDRTOPCITransfer(pciDev: U8): U32
DMA_DDRTODDRTransfer(pciDev: U8): U32
DMA_DDRTODDRTransfer(): U32
CACHE_ModeChangeTest(): U32
NVSRAM_retention_write_test(pattern: U8): U32
NVSRAM_retention_read_test(pattern: U8): U32
NVSRAM_CopyMtcSudbToNvram(): U32
NVSRAM_SetupNvram(): U32
FLASH_ISPEDAreaErased(): bool
FLASH_TCMTC_SudbCrcCheck(): U32
```

```
TiApi_OurMenu
DisplayMenu(): void
DisplayLedSubMenu(): void
Enter(): void
EnterLedSubMenu(): void
DumpMemAddr(): void
MCardPowerOnOff_Periodically(): void
DisplayKeypadValue(): void
FLASH_ErasePfdSector(): void
EnableTimerInterrupt(): void
DisableTimerInterrupt(): void
RS232 EnableOutput(): void
RS232_DisableOutput(): void
DisplayRunningStr(str:char*, keyMatch: U16*, nrKeyMatches:int):void
DisplayLongStr_By4_UntilKeyInMatch(str:char*, keyMatch:U16*, nrKeyMatches:int):void
Led_ErrCodeRun(): void
Led_ErrCode4() : void

MCard_PowerOnOffPeriodically(ms : int) : void
```

```
TiApi_Peripheral

USB_Test(port: U8): U32
ETHERNET_SingleInterLoopTest(): U32
SATA_DiskTest(port: U8): U32
FPIR_Test(key: U8*, timeout: U32): U32
FPKEYPAD_Test(): U32
FPLED_Test(): U32
ACOUTLET_Test(bStatus: bool): U32
```

#### 1.6. TiLib

The layer be called by layer TiApi or above.

```
<mark>✓</mark>digAV : TiLib_DigAV

✓ frontEnd : TiLib_FrontEnd

peripheral : TiLib_Peripheral
mCard : TiLib_MCard
✓memory : TiLib_Memory
✓keypad : TiLib_Keypad
vir:TiLib IR

√rs232 : TiLib_RS232

✓led : TiLib_Led
✓tvMonCmd : TiLib_TvMonCmd
TiLib()
DelayMS(ms: U32): void
GetProductModel(model: S8*): U32
SProductModel(model: S8*): bool
Init() : void
```

```
enum PeripheralChip
 CT_MAIN_CHIP=0, // CT_: ChipType
CT_DEMOD,
CT_1394CHIP,
  CT_MPEG2_ENCODER,
  CT_ENTROPIC,
  CT_BOARD_ID,
 CT_PSOC_FAN,
CT_PSOC_FP
                           TiLib_Chip
    GetMainChip(regAddr : U32) : U32
GetPClDev(chip : PeripheralChip) : U32
Getl2CDev(chip : PeripheralChip) : U32
    Getize Dev(Criip : Pe
GetBoardID() : U32
OHCI_Test() : U32
```

### TiLib DigAV hHDMI: BHDM\_Handle atestStream : int Init() : void AUDIO\_OpenOutput\_Optical(): U32 AUDIO\_OpenOutput\_Coaxial(): U32 AUDIO\_SelSrc(stream: int, ulPcrPid: U32, ulAudPid: U32): U32 AUDIO\_Start1KTone(stream : U32) : U32 VIDEO\_EnableCompositeAndComponent(stream : int) : void VIDEO\_SelSrc(stream : int, ulPcrPid : U32, ulVidPid : Ú32) : void VIDEO\_PIPDisplay() : void VIDEO SetComponetFormatTo480I(stream : int) : U32 BypassCableCard(): U32 RouteToCableCard(): U32 SOpen\_1394(stream : int) : bool OpenOutput\_Composite(): U32 OpenOutput\_Component(): U32 OpenOutput\_Hdmi(): U32 OpenOutput\_1394() : U32 OpenOutput\_SVideo(): U32 OpenOutput\_RF(): U32 OpenOutput\_802\_11() : U32 OpenOutput\_Ethernet(): U32 CloseOutput\_Composite(): U32 CloseOutput\_Component(): U32 CloseOutput\_Hdmi(): U32 CloseOutput\_RF(): U32 VidOut\_EnablePip(eDisp: etDisplay, eSurf: etSurface, eSrc: etVideoSource): void

```
enum VCXO_Frequency_Set {
   VCXO_27_H=0,
   VCXO_27_M,
   VCXO_27_L,
   VCXO_25_GPIO_Output
};
```

```
TiLib_FrontEnd

INB_Parameter: INB_INIT_ARG
OOB_Parameter: OOB_INIT_ARG

OOB_Frequency_Set(Freq_Sel: eOOB_Freq_Sel): eTiLib_OOB_Error
OOB_ACQ(: void): eTiLib_OOB_Error
OOB_LockStatus_Get(: void): eTiLib_OOB_Error
INB_INIT(: void): U32

QAM_SymboyRate_Set(DS_Port: eINB_Channel_Sel, DeMod_Sel: eINB_DeMod_Sel): U32
QOM_IF_AGC_Control_Set(Type_IF_AGC: int): U32
OOB_INIT(: void): U32
OOB_SymboyRate_Set(: void): U32
```

```
RFU
(from TiLib_FrontEnd)

SetFrequency(ulSetFreqKhz: U32): eRfUpstreamError_t
SetPowerLevel(fPowerDbmv: U32): eRfUpstreamError_t
GetPowerLevel(fPowerDbmv: U32 &): eRfUpstreamError_t
Calibrate(offset: float*): eRfUpstreamError_t
ReadPowerFromPowerMeter(freq: U32, powerLevelDbm: U32*): int
CheckPower(freq: U32, powerLevelDbm: U32): int
```

```
CLink
(from TiLib_FrontEnd)

CLink_Parameter: CLink_INIT_ARG

CLink_Device_Identify(PCI_Id: U16 &, Chip_Version: U16 &): eTiLib_CLink_Error

CLink_CO_Channel_Tune(CO_ChNum: U16): eTiLib_CLink_Error

CLink_CW_Channel_Tune(CW_ChNum: U16): eTiLib_CLink_Error

CLink_INIT(: void): U32
```

<<struct>> TiLib KeyTable key: KEYTYPE ⊘name : S8 \*

TiLib\_Keypad key: KEYTYPE longPressed : bool Read(): KEYTYPE ReadWithCount(count : U32) : KEYTYPE SetDebounce(debounce : U8) : void Init() : void GetKey() : KEYTYPE GetKey\_U16() : U16 GetKeyWithCount(count : U32) : KEYTYPE LongPressed(): bool GetKeyName(key : KEYTYPE) : S8\*

TiLib\_IR 🕸\_hIRChan : BKIR\_ChannelHandle interruptDevice: BKIR\_KirInterruptDevice TiLib\_IR() ~TiLib\_IR() Init(): void GetKey() : U8
ClearData() : void

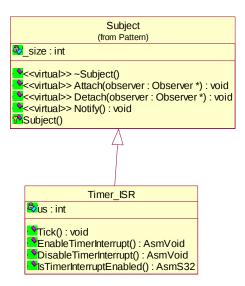
TiLib Led \_hLed : BLED\_Handle Display\_4Digits(ulDisplay : U32) : void TiLib\_Led()
Init(): void FrontOn(bits : char) : void FrontOff(bits : char) : void DisplayStr(str : char \*) : void conOn(iconId : unsigned char) : void conOff(iconId : unsigned char) : void AllOn(): void FastSpin(nn : U32) : void SlowSpin() : void DisplayChar(c : char, pos : int) : void

TiLib\_RS232 addr : volatile UartChannel \* mode : UartMode outputEnable : bool TiLib\_RS232(port : U32) SoutputEnabled(): bool EnableOutput(): bool DisableOutput(): bool RxByte(rxByte: U8\*): U32 Strandle(): bool EnableTxRx(): bool DisableTxRx(): bool SetUartMode(mode : UartMode) : UartMode Print(pcFormat : S8\*, : ...) : int GetLine(pcBuf : S8\*, IBufSize : S32) : void Print\_WithArg(pcFormat : S8\*, ap : va\_list) : int GetLine\_WithTimeOut(pcBuf : S8\*, lBufSize : S32, timeout\_us : U32) : bool GetKey(): U8 ClearData(): void

TiLib MCard slnit() : bool Dolnit(): U32 OpenŠession(): U32 RouteOOBToCableCard(): U32

TiLib\_Memory DDR\_Full\_Test(testPattern : U32\*, startAddr : U32, size : U32) : U32 DMA\_DDRTo325x(): U32 DMA\_325xToDDR() : U32 NVSRAM\_CheckMtcSudbInAddr(pSrc : U8\*, pDest : U8\*, uwBytes : U16) : U32 NVSRAM\_CheckMtcSudb(): U32 FLASH boot protect(pFlashDriver: FlashDriver\*): U32 DDR\_Cross\_Test(testPattern: U32\*, startAddr: U32, size: U32): U32 DMA\_DDRToDDR(): U32

TiLib\_Peripheral USB\_CheckVendorDeviceId(str : S8\*) : U32 AC\_Outlet\_Init(): U32 AC\_Outlet\_Status(bStatus: bool): U32 WatchDog\_Disable() : void

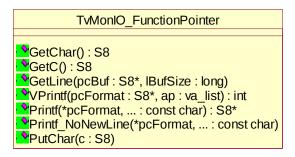


### 1.7. TvMonCmd

```
TiLib_TvMonCmd

RunCmdsInMenu(cmd : char* [], menu : S16 (*)( S8 * pcParm1, BOOL bHelpQuery )) : void
RunCmdsNlnMenu(cmd : char* [], size : U16, menu : S16 (*)( S8 * pcParm1, BOOL bHelpQuery )) : void
RunCmds(cmd : char* []) : void
RunCmdsN(cmd : char* [], size : U16) : void
```

### 1.8. TvMonIO Function Pointer and TvMonIO (in Broadcom Hal Layer)



```
TvMonIO

init(): void
clear(): void
out_getResult(pBegin: S8*, leadPattern: S8*, result: S8*): U32
out_getResultN(pBegin: S8*, leadPattern: S8*, result: S8*, resultLength: U16): U32
toRs232(): void
toSdram(): void
```

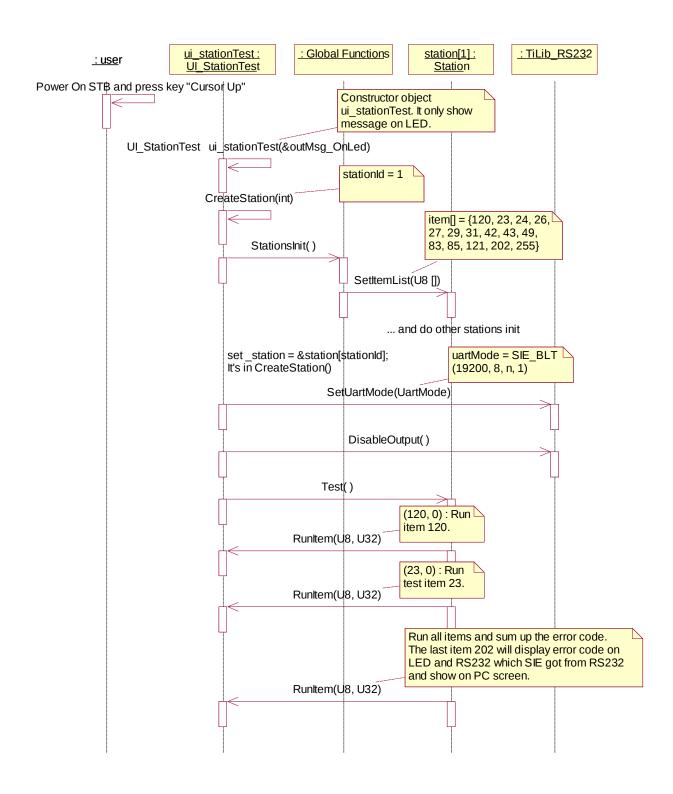
### 2. SEQUENCE DIAGRAM

This section using sequence diagram to describes how objects co-work to finish the system functions. UI\_DebugTest and UI\_StationTest are described in 6.1 User Interface. Some test items are described in 6.2 Items.

### 2.1. User Interface

UI\_StationTest:





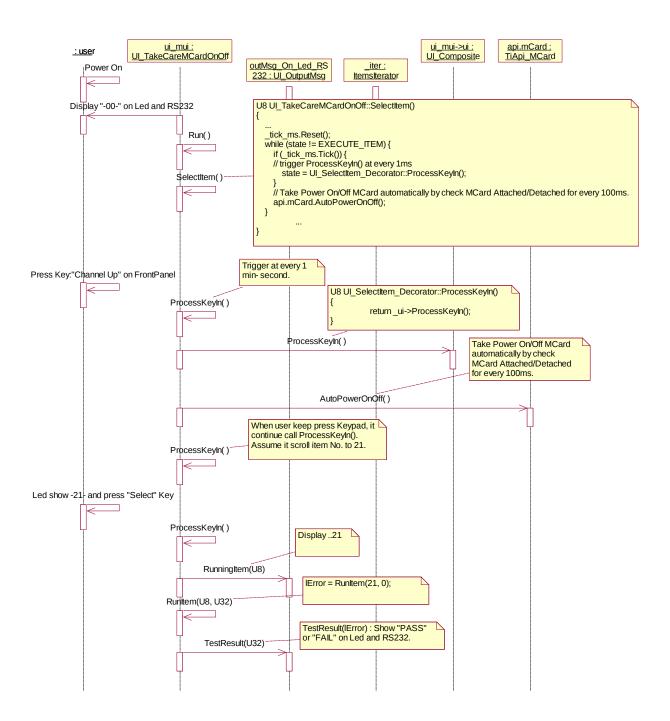
### UI\_DebugTest:

It will damage a few IC in STB during MCard working on AV test. So, add this UI\_TakeCareMCardOnOff to prevent and limit these code in this class. The ui\_mui is an object as type of class UI\_TakeCareMCardOnOff, and include object ui\_mui->ui which include 3 UI objects, UI\_FrontPanel, UI\_IR and UI\_RS232.

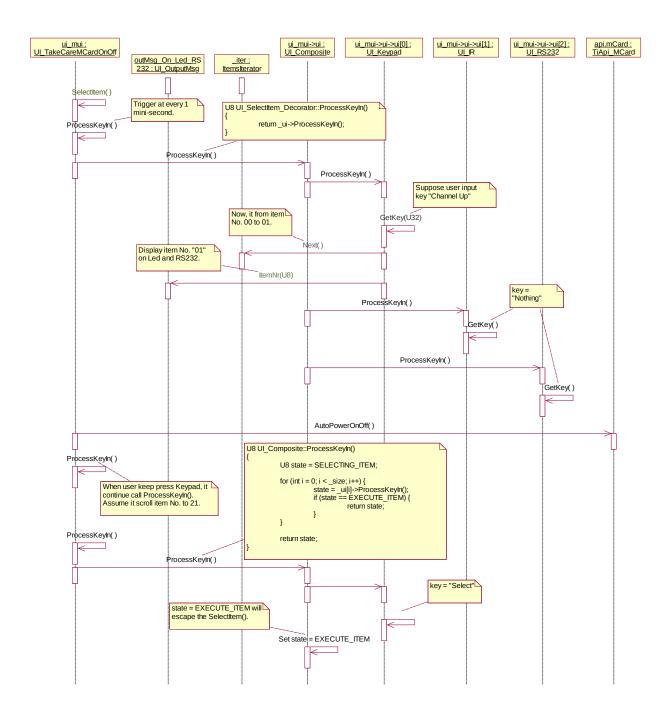
SelectItem() will Scroll item No. when user press "Channel Up" or "Channel Down", and escape while loop when press key "Select".

The sequence diagram as follow,





The SelectItem() part as follow,



### 2.2. Items

Run Item with Time Out:

I implement the time out mechanism and used in every test items. BLTC give every test item a time limit to run. If it over, then treat this test item is FAIL. The reasons for time out mechanism as follow,

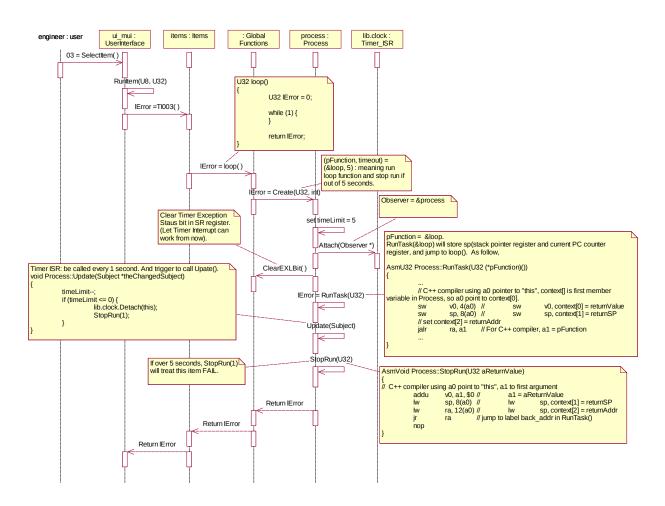
1. Sometimes especially in EPR or PPR stage (still in implement new test item), BLTC will hang on the test items, for example, the Ethernet Loop Test Item, SATA Test Item, and Flash Vendor ID Test Item will have chance to hang on forever (I

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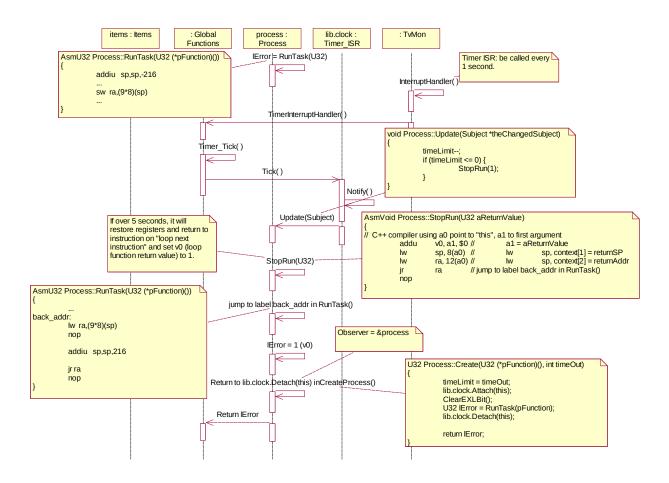
have this experience in DCT34xx and DCH P5 and QIP7216 EPR, and I know it came from the TvMon Layer in some special test order). When it happen, the whole station test cannot go on, and we have no idea to go on. The only way to run the EPR is by skip the whole station test and ask operator to run single item test, one by one. With this mechanism, I don't have to worry about this situation any more (it's a nightmare).

2. BLTC abandoned the solution that stop test as soon as it meet FAIL in run any test item. It run all test items of station and display error code. It's better for rework (find all bad part at one time).

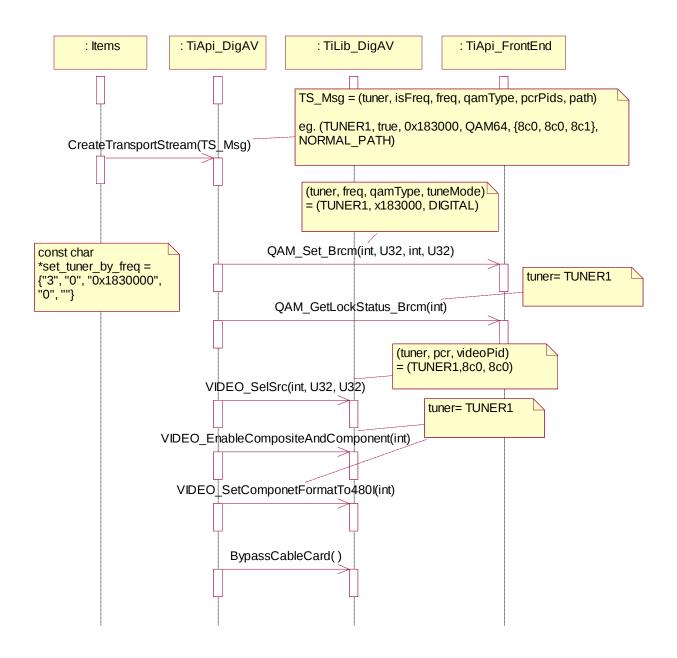
웃



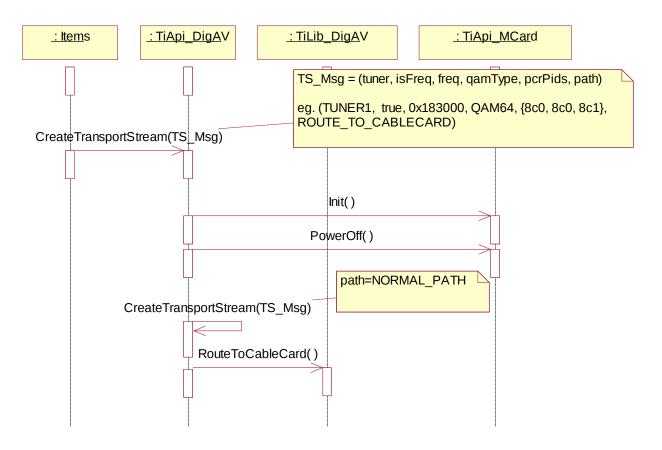
Run Item with Time Out::Process::Update() part,



DigAV\_CreateTransportStream(NORMAL\_PATH)

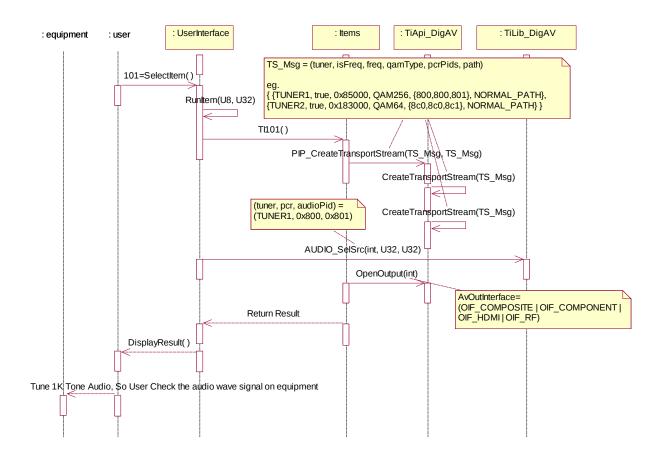


 $DigAV\_CreateTransportStream(ROUTE\_TO\_CABLECARD)$ 



### Digital AV PIP Test (Normal Path)





### Digital AV Test (CableCard and 1394)



